

Search Notes

Application/Control No.

10/724,116

Examiner

Emmanuel Bayard

Applicant(s)/Patent under
Reexamination

MAGOON ET AL.

Art Unit

2631

SEARCHED

Class	Subclass	Date	Examiner
325	298	6/6/05	aihs
		↑	↑
326			
327			
329			
323			
321			
325			
326	294		
327	3		
328	156		
327	147		
329	307		
328	345	↓	↓
329	346	6/6/05	aihs

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
aihsf	6/6/05	ci3

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner